## 

#### FEATURES

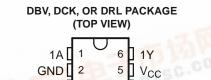
- Available in the Texas Instruments NanoStar<sup>™</sup> and NanoFree<sup>™</sup> Packages
- Supports 5-V V<sub>CC</sub> Operation
- Inputs Accept Voltages to 5.5 V
- Max t<sub>pd</sub> of 4.1 ns at 3.3 V
- Low Power Consumption, 10-µA Max I<sub>CC</sub>
- 24-mA Output Drive at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce) < 0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25 C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot) > 2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25 C
- Ioff Supports Partial-Power-Down Mode
  Operation
- Latch-Up Performance Exceeds 100 mA Per JESD 78, Class II
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)

### **DESCRIPTION/ORDERING INFORMATION**

This dual buffer gate is designed for 1.65-V to 5.5-V  $V_{CC}$  operation. The SN74LVC2G34 performs the Boolean function Y = A in positive logic.

NanoStar<sup>™</sup> and NanoFree<sup>™</sup> package technology is a major breakthrough in IC packaging concepts, using the die as the package.

This device is fully specified for partial-power-down applications using I<sub>off</sub>. The I<sub>off</sub> circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.



SN74LVC2G34

DUAL BUFFER GATE

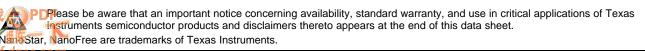
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2Y

#### YEA, YEP, YZA, OR YZP PACKAGE (BOTTOM VIEW)

2A

1			
2A	03	40	2Y
GND	02	50	Vcc
1A	01	60	1Y
GND 1A	02 01	50 60	V <sub>C</sub> 1Y



多邦,专业PCB打样工厂,24小时加急出货

## SN74LVC2G34 **DUAL BUFFER GATE**

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ORDERING INFORMATION								
T <sub>A</sub>	PACKAGE <sup>(1)</sup>		ORDERABLE PART NUMBER	TOP-SIDE MARKING <sup>(2)</sup>				
	NanoStar™ – WCSP (DSBGA) 0.17-mm Small Bump – YEA	- Reel of 3000	SN74LVC2G34YEAR					
	NanoFree™ – WCSP (DSBGA) 0.17-mm Small Bump – YZA (Pb-free)		SN74LVC2G34YZAR					
	NanoStar™ – WCSP (DSBGA) 0.23-mm Large Bump – YEP		SN74LVC2G34YEPR	C9_				
–40°C to 85°C	NanoFree™ – WCSP (DSBGA) 0.23-mm Large Bump – YZP (Pb-free)		SN74LVC2G34YZPR					
		Reel of 3000	SN74LVC2G34DBVR	624				
	SOT (SOT-23) – DBV	Reel of 250	SN74LVC2G34DBVT	- C34_				
		Reel of 3000	SN74LVC2G34DCKR	00				
	SOT (SC-70) – DCK	Reel of 250	SN74LVC2G34DCKT	- C9_				
	SOT (SOT-533) – DRL	Reel of 4000	SN74LVC2G34DRLR	PREVIEW				

#### ORDERING INFORMATION

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

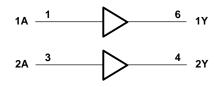
(2)

DBV/DCK: The actual top-side marking has one additional character that designates the assembly/test site. YEA/YZA, YEP/YZP: The actual top-side marking has three preceding characters to denote year, month, and sequence code, and one following character to designate the assembly/test site. Pin 1 identifier indicates solder-bump composition (1 = SnPb, · = Pb-free).

#### **FUNCTION TABLE** (EACH GATE)

INPUT A	OUTPUT Y
Н	Н
L	L

#### LOGIC DIAGRAM (POSITIVE LOGIC)





### SN74LVC2G34 **DUAL BUFFER GATE**

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### Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range	-0.5	6.5	V	
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Voltage range applied to any output in the h	high-impedance or power-off state <sup>(2)</sup>	-0.5	6.5	V
Vo	Voltage range applied to any output in the h	high or low state <sup>(2)(3)</sup>	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>0</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current			50	mA
	Continuous current through $V_{CC}$ or GND			100	mA
		DBV package		165	
		DCK package		259	
$\theta_{JA}$	Package thermal impedance <sup>(4)</sup>	DRL package		142	C/W
		YEA/YZA package		143	
		YEP/YZP package		123	
T <sub>stg</sub>	Storage temperature range		-65	150	С

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating" conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed. (2)

(3) The value of V<sub>CC</sub> is provided in the recommended operating conditions table.
 (4) The package thermal impedance is calculated in accordance with JESD 51-7.





# Recommended Operating Conditions<sup>(1)</sup>

				MIN		MAX	UNIT
	Quere la construcción de la constru	Operating		1.65		5.5	
V <sub>CC</sub>	Supply voltage	Data retention only		1.5			V
		V <sub>CC</sub> = 1.65 V to 1.95 V	0.65	$V_{CC}$			
V		$V_{CC}$ = 2.3 V to 2.7 V		1.7			V
V <sub>IH</sub>	High-level input voltage	$V_{CC}$ = 3 V to 3.6 V		2			v
		$V_{CC}$ = 4.5 V to 5.5 V	0.7	$V_{CC}$			
	V <sub>CC</sub> = 1.65 V to 1.95 V			0.35	$V_{CC}$		
V		$V_{CC}$ = 2.3 V to 2.7 V				0.7	V
V <sub>IL</sub>	Low-level input voltage	$V_{CC} = 3 V \text{ to } 3.6 V$				0.8	v
		$V_{CC}$ = 4.5 V to 5.5 V			0.3	$V_{CC}$	
VI	Input voltage			0		5.5	V
Vo	Output voltage			0		$V_{CC}$	V
	V <sub>CC</sub> = 1.65 V				-4		
		$V_{CC} = 2.3 V$				-8	
I <sub>OH</sub>	High-level output current	$V_{CC} = 3 V$				-16	mA
		$v_{CC} = 5 v$				-24	-
		$V_{CC} = 4.5 V$				-32	
		V <sub>CC</sub> = 1.65 V				4	
		$V_{CC} = 2.3 V$				8	
I <sub>OL</sub>	Low-level output current	$V_{CC} = 3 V$	16		mA		
		v <sub>CC</sub> = 3 v				24	
		$V_{CC} = 4.5 V$				32	
		$V_{CC} = 1.8 \text{ V}$ 0.15 V, 2.5 V 0.2 V				20	
?t/?v	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \qquad 0.3 \text{ V}$				10	ns/V
		$V_{CC} = 5 V$ 0.5 V				5	
T <sub>A</sub>	Operating free-air temperature			-40		85	С

(1) All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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#### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V <sub>cc</sub>	MIN TYP <sup>(1)</sup> MAX	UNIT			
	$I_{OH} = -100 \ \mu A$	1.65 V to 5.5 V	V <sub>CC</sub> – 0.1				
	$I_{OH} = -4 \text{ mA}$	1.65 V	1.2				
M	$I_{OH} = -8 \text{ mA}$	2.3 V	1.9	V			
V <sub>OH</sub>	$I_{OH} = -16 \text{ mA}$	3 V	2.4	v			
	$I_{OH} = -24 \text{ mA}$	3 V	2.3				
	$I_{OH} = -32 \text{ mA}$	4.5 V	3.8	-			
	I <sub>OL</sub> = 100 μA	1.65 V to 5.5 V	0.1				
	I <sub>OL</sub> = 4 mA	1.65 V 0		5			
M	I <sub>OL</sub> = 8 mA	2.3 V	0.3	V			
V <sub>OL</sub>	I <sub>OL</sub> = 16 mA	2.1/	0.4	V			
	I <sub>OL</sub> = 24 mA	3 V	0.55				
	I <sub>OL</sub> = 32 mA	4.5 V	0.55				
I <sub>I</sub> A inputs	$V_{I} = 5.5 \text{ V or GND}$	0 to 5.5 V	5	μA			
l <sub>off</sub>	$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$	0	10	μA			
I <sub>CC</sub>	$V_{I} = 5.5 \text{ V or GND}, I_{O} = 0$	1.65 V to 5.5 V	10	μA			
?I <sub>CC</sub>	One input at $V_{CC}$ – 0.6 V, Other inputs at $V_{CC}$ or GND	3 V to 5.5 V	500	μA			
Ci	$V_{I} = V_{CC} \text{ or } GND$	3.3 V	3.5	pF			

(1) All typical values are at V<sub>CC</sub> = 3.3 V,  $T_A$  = 25 C.

#### **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = 0.1	1.8 V 5 V	V <sub>CC</sub> = 2 0.2	2.5 V 2 V	V <sub>CC</sub> = 3 0.3	3.3 V 3 V	V <sub>CC</sub> = 0.9	5 V 5 V	UNIT
		(001-01)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t <sub>pd</sub>	А	Y	3.2	8.6	1.5	4.4	1.4	4.1	1	3.2	ns

### **Operating Characteristics**

 $T_{A} = 25$  C

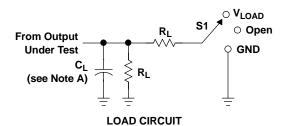
PARAMETER		TEST CONDITIONS	V <sub>CC</sub> = 1.8 V	V <sub>CC</sub> = 2.5 V	V <sub>CC</sub> = 3.3 V	$V_{CC} = 5 V$	UNIT
		TEST CONDITIONS	TYP	TYP	ТҮР	TYP	UNIT
C <sub>pd</sub>	Power dissipation capacitance	f = 10 MHz	14	14	15	17	pF

#### SN74LVC2G34 DUAL BUFFER GATE

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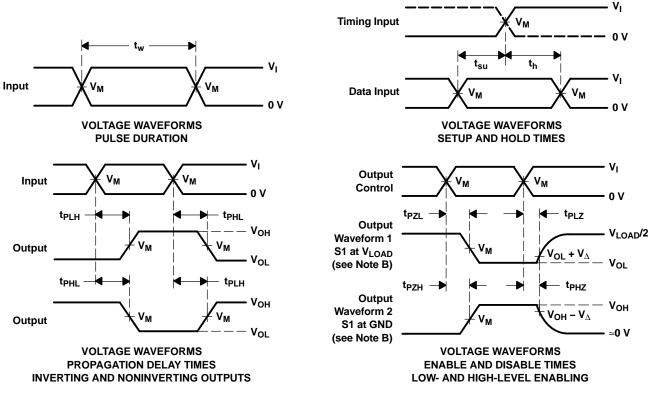


#### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

INPUTS V<sub>CC</sub> CL  $V_{\Lambda}$ Vм VLOAD RL V t<sub>r</sub>/t<sub>f</sub>  $\textbf{1.8 V} \pm \textbf{0.15 V}$ 30 pF 0.15 V V<sub>CC</sub> ≤2 ns V<sub>CC</sub>/2  $2 \times V_{CC}$ **1 k**Ω 30 pF **500** Ω  $\textbf{2.5 V} \pm \textbf{0.2 V}$ **≤2 ns** V<sub>CC</sub>/2  $2 \times V_{CC}$ 0.15 V Vcc 1.5 V 50 pF **500** Ω  $\textbf{3.3 V} \pm \textbf{0.3 V}$ 3 V ≤2.5 ns 6 V 0.3 V 5 V  $\pm$  0.5 V Vcc ≤2.5 ns V<sub>CC</sub>/2 50 pF **500** Ω 0.3 V  $2 \times V_{CC}$ 



NOTES: A. C<sub>L</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
  C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>Q</sub> = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

#### Figure 1. Load Circuit and Voltage Waveforms



## PACKAGE OPTION ADDENDUM

5-Dec-2005

#### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
SN74LVC2G34DBVR	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34DBVRE4	ACTIVE	SOT-23	DBV	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34DCKR	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34DCKRE4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34DCKRG4	ACTIVE	SC70	DCK	6	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34DRLR	ACTIVE	SOP	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34DRLRG4	ACTIVE	SOP	DRL	6	4000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74LVC2G34YEAR	ACTIVE	WCSP	YEA	6	3000	TBD	SNPB	Level-1-260C-UNLIM
SN74LVC2G34YEPR	ACTIVE	WCSP	YEP	6	3000	TBD	SNPB	Level-1-260C-UNLIM
SN74LVC2G34YZAR	ACTIVE	WCSP	YZA	6	3000	Pb-Free (RoHS)	SNAGCU	Level-1-260C-UNLIM
SN74LVC2G34YZPR	ACTIVE	WCSP	YZP	6	3000	Pb-Free (RoHS)	SNAGCU	Level-1-260C-UNLIM

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

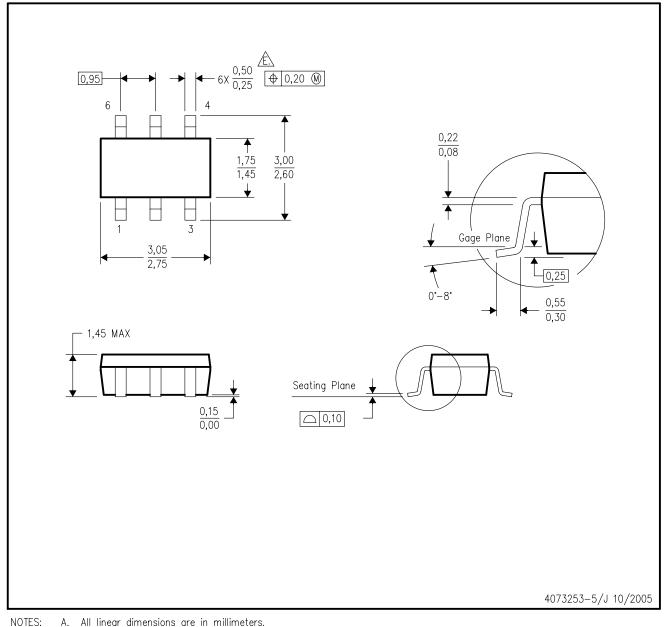
<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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DBV (R-PDSO-G6)

## PLASTIC SMALL-OUTLINE PACKAGE



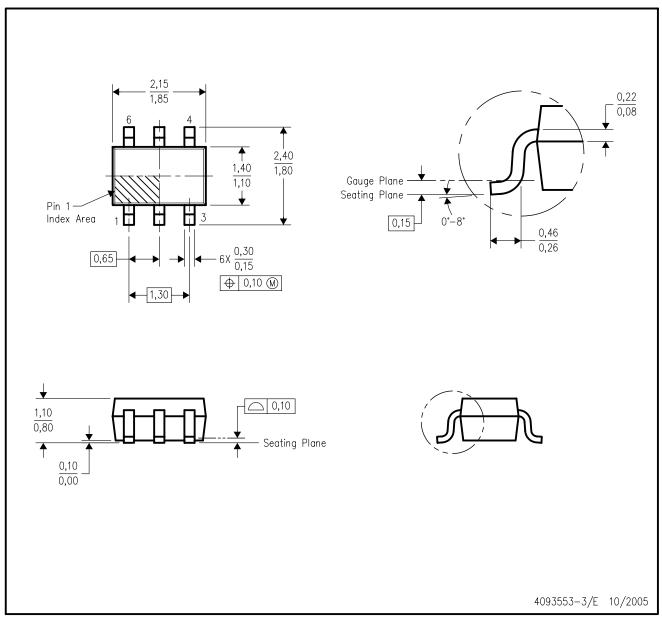
A. All linear dimensions are in millimeters.

- This drawing is subject to change without notice. Β.
- Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side. Leads 1,2,3 may be wider than leads 4,5,6 for package orientation. C.
- D.
- E Falls within JEDEC MO-178 Variation AB, except minimum lead width.



DCK (R-PDSO-G6)

### PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A

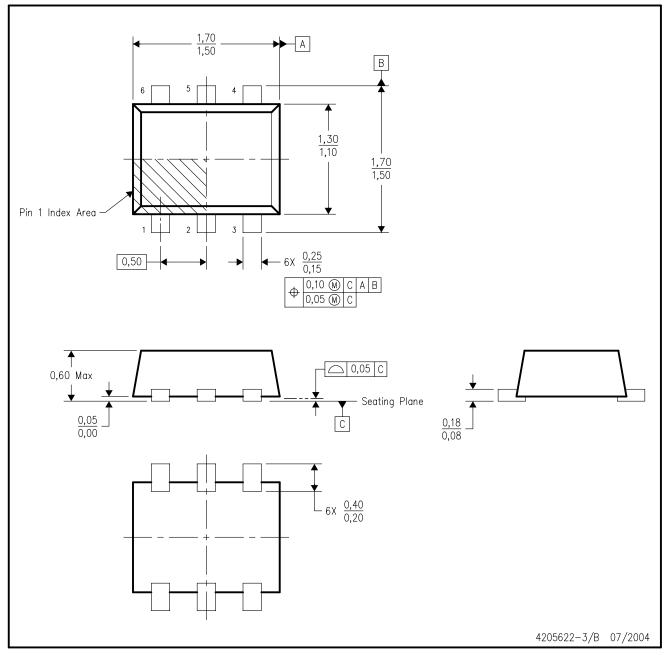
A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side.
- D. Falls within JEDEC MO-203 variation AB.



# DRL (R-PDSO-N6)

## PLASTIC SMALL OUTLINE



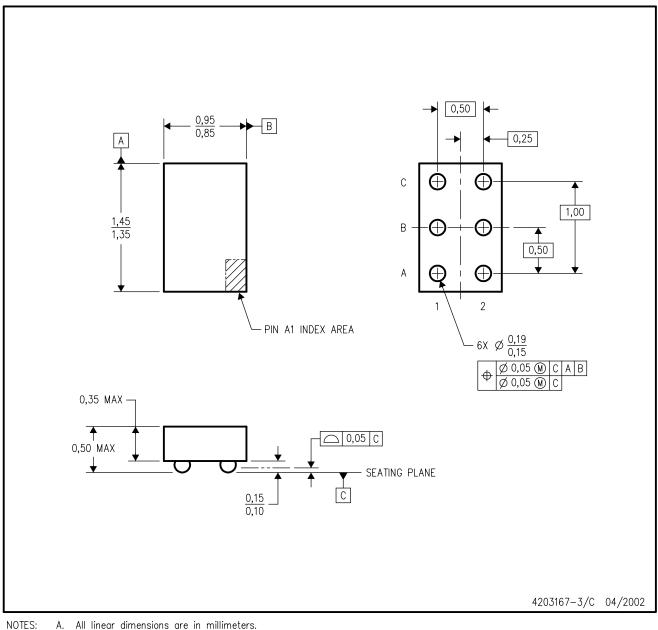
NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. JEDEC package registration is pending.



YEA (R-XBGA-N6)

### DIE-SIZE BALL GRID ARRAY



NOTES:

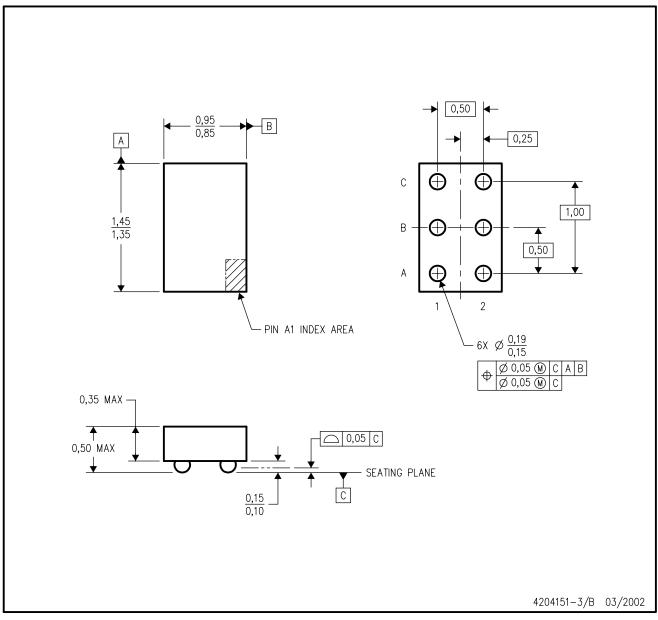
- This drawing is subject to change without notice. Β.
- C. NanoStar™ package configuration.
- D. Package complies to JEDEC MO-211 variation EA.
- E. This package is tin-lead (SnPb). Refer to the 6 YZA package (drawing 4204151) for lead-free.

NanoStar is a trademark of Texas Instruments.



YZA (R-XBGA-N6)

### DIE-SIZE BALL GRID ARRAY



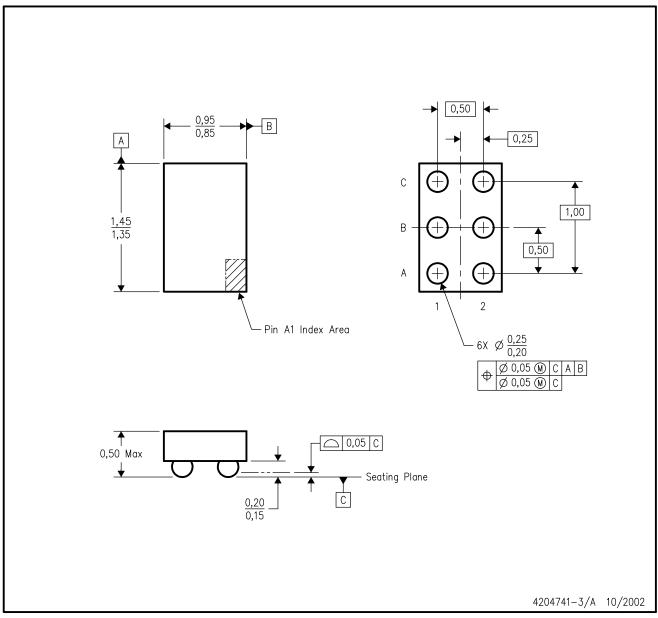
NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. Package complies to JEDEC MO-211 variation EA.
- E. This package is lead-free. Refer to the 6 YEA package (drawing 4203167) for tin-lead (SnPb).

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YZP (R-XBGA-N6)

DIE-SIZE BALL GRID ARRAY



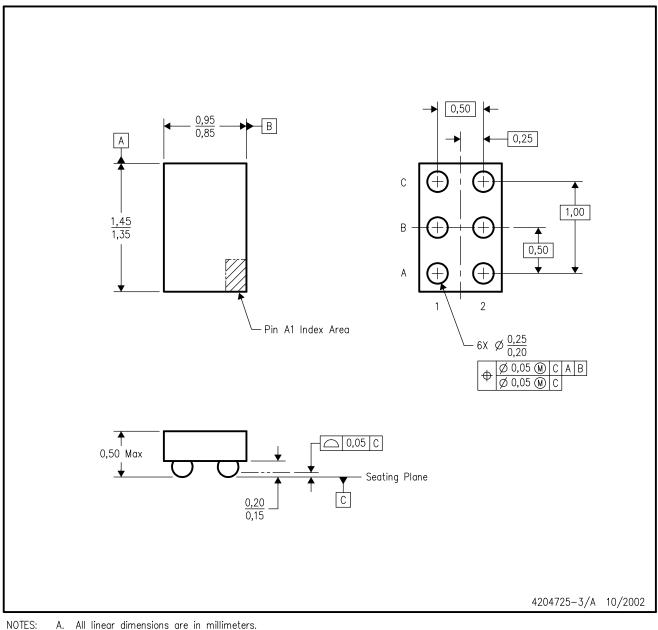
NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. NanoFree™ package configuration.
- D. This package is lead-free. Refer to the 6 YEP package (drawing 4204725) for tin-lead (SnPb).

NanoFree is a trademark of Texas Instruments.

YEP (R-XBGA-N6)

### DIE-SIZE BALL GRID ARRAY



NOTES:

- This drawing is subject to change without notice. Β.
- C. NanoStar™ package configuration.
- D. This package is tin-lead (SnPb). Refer to the 6 YZP package (drawing 4204741) for lead-free.

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